



Test report No: 2040805R-RF-US-P20V01

SAR Exemption Evaluation Report

Product Name	EZ-BT WICED Module
Trademark	Cypress
Model and /or type reference	CYBT-213066-02, CYBT-213067-02
FCC ID	AP3066
Applicant's name / address	Cypress Semiconductor Technology (Shanghai) Co., Ltd. 198 Champion Ct, San Jose, California 95134, United States
Test method requested, standard	KDB 447498D01V06 FCC Part1.1310
Verdict Summary	IN COMPLIANCE
Documented by (name / position & signature)	Kitty Li/Project Assistant
Reviewed by (name / position & signature)	Frank He/ Technical Supervisor
Approved by (name / position & signature)	Jack Zhang/ Supervisor Jack Zhang/ Supervisor
Date of issue	2020-06-03
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GENERAL CONDITIONS

Test Location	No. 99, Hongye Road, Suzhou Industrial Park Suzhou, 215006, P.R. China
Date(receive sample)	Apr. 29, 2020
Date (start test)	May. 01, 2020
Date (finish test)	May. 25, 2020

- 1. This report is only referred to the item that has undergone the test.
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ENVIRONMENTAL CONDITIONS

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment. The climatic conditions during the tests were within the following limits:

Ambient temperature	15 °C – 35 °C
Relative Humidity air	30% - 60%

If explicitly required in the basic standard or applied product / product family standard the climatic values are recorded and documented separately in this test report.

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POSSIBLE TEST CASE VERDICTS

Test case does not apply to test object	N/A
Test object does meet requirement	P (Pass) / PASS
Test object does not meet requirement	F (Fail) / FAIL
Not measured	N/M

ABBREVIATIONS

For the purposes of the present document, the following abbreviations apply:

EUT : Equipment Under Test

QP : Quasi-Peak
CAV : CISPR Average

AV : Average

CDN : Coupling Decoupling Network
SAC : Semi-Anechoic Chamber
OATS : Open Area Test Site

BW : Bandwidth

AM : Amplitude Modulation PM : Pulse Modulation

HCP : Horizontal Coupling PlaneVCP : Vertical Coupling Plane

 $U_{\rm N}$: Nominal voltage

Tx: TransmitterRx: ReceiverN/A: Not ApplicableN/M: Not Measured

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DOCUMENT HISTORY

Report No.	Version	Description	Issued Date
2040805R-RF-US-P20V01	V1.0	Initial issue of report.	2020-06-03

REMARKS AND COMMENTS

- 1. The equipment under test (EUT) does meet the essential requirements of the stated standard(s)/test(s).
- 2. These test results on a sample of the device are for the purpose of demonstrating Compliance with KDB 447498 and FCC Part 1.1310
- 3. The measurement result is considered in conformance with the requirement if it is within the prescribed limit, It is not necessary to account the uncertainty associated with the measurement result, unless the specification, standard or customer have special requirements
- 4. The test results relate only to the samples tested.
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1. RF Exposure Evaluation

1.1. Limits

According to KDB 447498 D01 General RF Exposure Guidance v06

- 4.3.1 Standalone SAR test exclusion considerations
- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR,where

- f(GHz) is the RF channel transmit frequency in GHz
- · Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- 3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 5) in section 4.1 is applied to determine SAR test exclusion.

- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following, and as illustrated in Appendix B:
- a) [Power allowed at numeric threshold for 50 mm in step 1) + (test separation distance 50 mm)·(f(MHz)/150)] mW, at 100 MHz to 1500 MHz
- b) [Power allowed at numeric threshold for 50 mm in step 1) + (test separation distance 50 mm)-10] mW at > 1500 MHz and \leq 6 GHz
- 3) The 1-g and 10-g SAR test exclusion thresholds for below 100 MHz at test separation distances ≤ 50 mm are determined by:
- a) The power threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(MHz))]$ for test separation distances > 50 mm and < 200 mm
- b) The power threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances \leq 50 mm
- c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable. Note: when the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

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1.2. Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.

The temperature and related humidity: 18°Cand 78% RH.

1.3. Test Result of RF Exposure Evaluation

Product	:	EZ-BT WICED Module
Test Item	:	RF Exposure Evaluation
Test Site		AC-6

Antenna information

Antonia information				
Antenna model / type number:	PCB antenna			
Antenna serial number:	N/A			
Antenna Delivery:	☐ 1TX + 1RX			
	☐ 2TX + 2RX			
Antenna technology				
		MIMO		CDD
				Beam-forming
Antenna Type:		External		Dipole
				Sectorized
	\boxtimes	Internal		PIFA
			\boxtimes	PCB
				Metal Monopole Antenna
				Others
Antenna Gain:	-0.5dl	3i		

Based on The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm and the formula below:

Estimated SAR=
$$\sqrt{f(GHz)} * \frac{\text{(Max Power of channel, mW)}}{\text{Min. Separation Distance, mm}}$$

The tune-up power is 0.5dB, so the maximum conducted power we used to calculate RF exposure is 4.63dBm.

Band	Exposure Condition	Pmax (dBm)	Pmax (mw)	Distance (mm)	f(GHz)	calculation result	Stand-alone Test exclusion threshold	SAR Test
BT	Body	4.63	2.90	5	2.48	0.91	3.00	No

Conclusion: 2.4	GHz SAR	was not	required.
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